

### Introduction to SEM-CL

ATE

Applications to geology

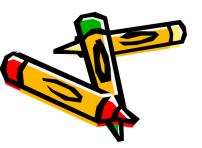
### Content

- Literatures
- Principle of Cathodoluminescence

aatar

- · SEM-CL
- Application of SEM-CL





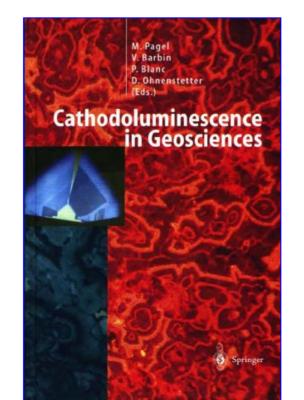
### Literatures

- Various Journal Papers
- ·CL books specialized in Geosciences

Cathodoluminescence of geological materials

D.J. Marshall

Unwin-Hyman Ltd.



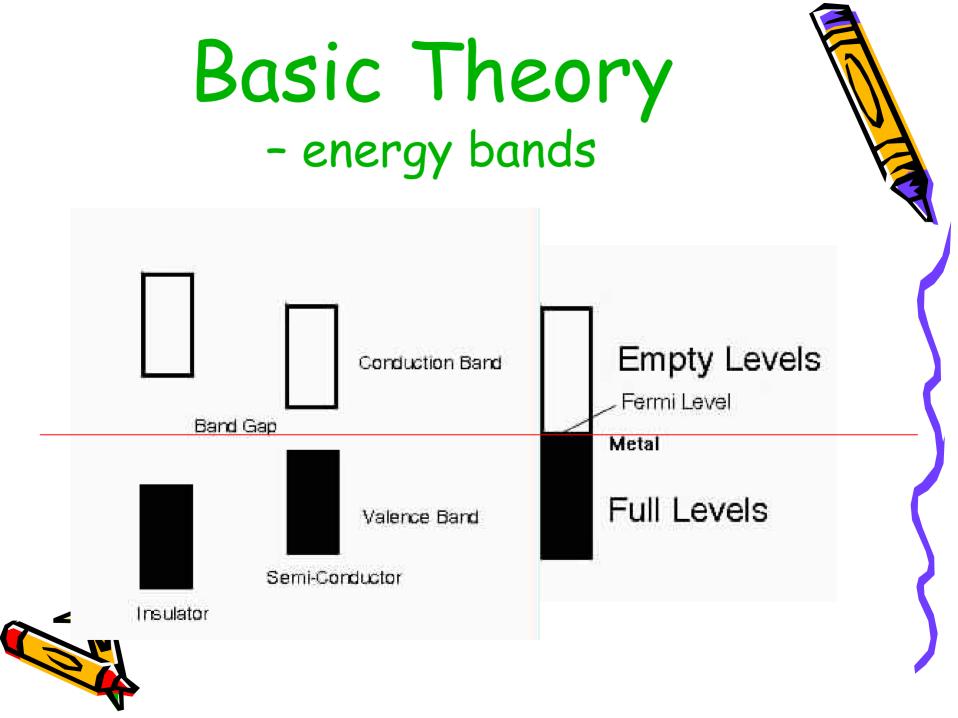


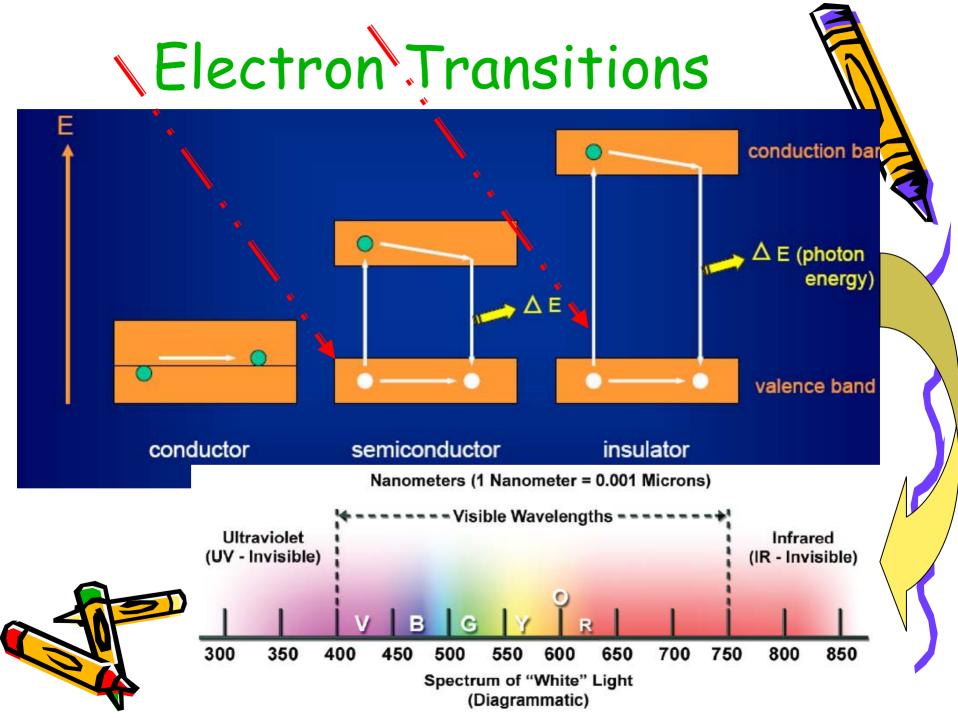
2000

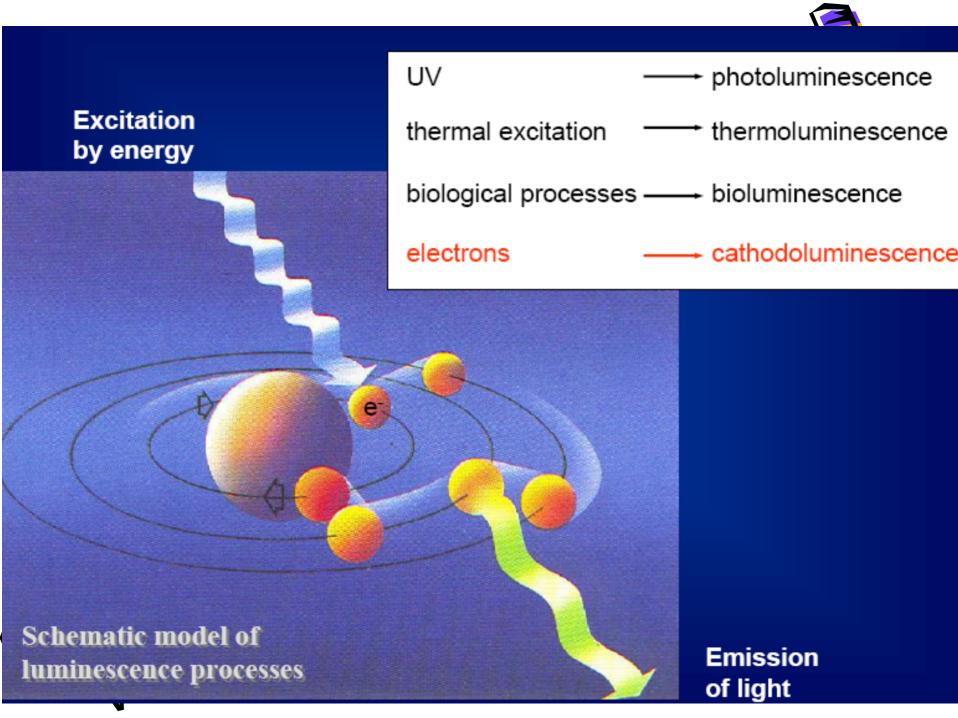
Cathodoluminescence microscopy and spectroscopy in applied mineralogy

Jens Götze

Geowissenschaften







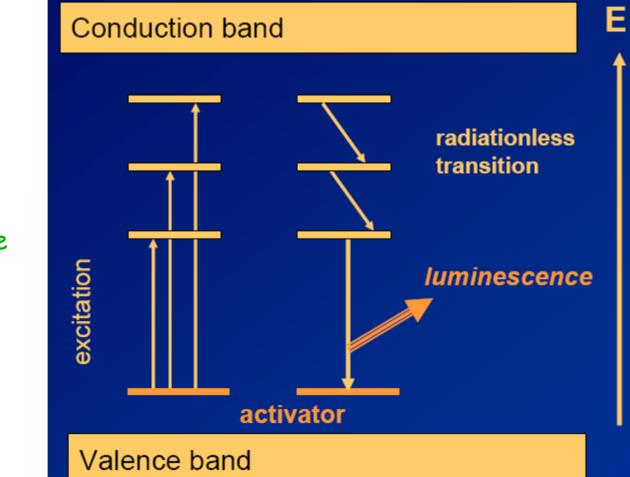
# Summary

- Metal -- non luminescence
- Semiconductor strong luminescence
- Insulator 1 weak luminescence compared to semiconductor
- Insulator 2 non luminescence due to large band gap



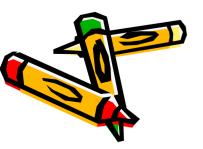
# **Defects and Impurities**

 Structural Defects and impurities in the solid modify the electron properties of materials (band structure)



Activators

Luminescence Center





hc

 $\overline{F}$ 

Photon Energy (E) Wavelength  $(\lambda)$ Frequency  $(c/\lambda)$ 

Planck's constant (h) Speed of Light (c)

 $h = 6.626 \times 10^{-34} \text{ J-s}$ ;  $c = 3.0 \times 10^{17} \text{ nm/sec}$ 

# Defects and Impurities $\lambda = \frac{hc}{E}$

Table 1. Proposed origins of cause based on impurities/defects

Wavelength	Proposed origin of cause [2]
175 nm	Intrinsic emission of pure SiO <sub>2</sub>
290 nm	Oxygen deficient center
340 nm	[AlO <sub>4</sub> /Li <sup>+</sup> ] center
380-390 nm	$[AlO_4/M^+]$ center, M=Li <sup>+</sup> , Na <sup>+</sup> , H <sup>+</sup>
420 nm	Intrinsic emission
450 nm	Intrinsic defect; self-trapped exciton
500 nm	$[AlO_4]^0$ center; $[AlO_4/M^+]$ center, M=Li <sup>+</sup> , Na <sup>+</sup> , H <sup>+</sup>
580 nm	Self-trapped exciton; E' center
620-650 nm	Oxygen vacancy, NBOHC with several precursors (e.g. OH <sup>-</sup> )
705 nm	Substitutional Fe <sup>3+</sup>

 $\lambda$  = wavelength

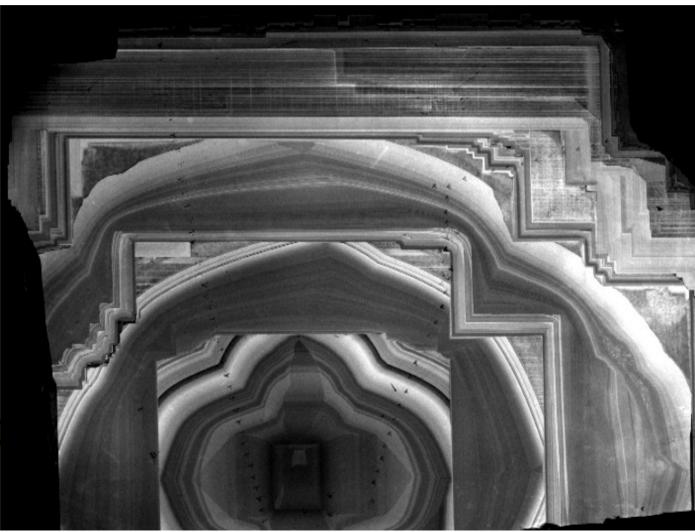
ΔE

Band

Gap

# Example -- diamond

#### Nitrogen Impurities in Diamond Crystal

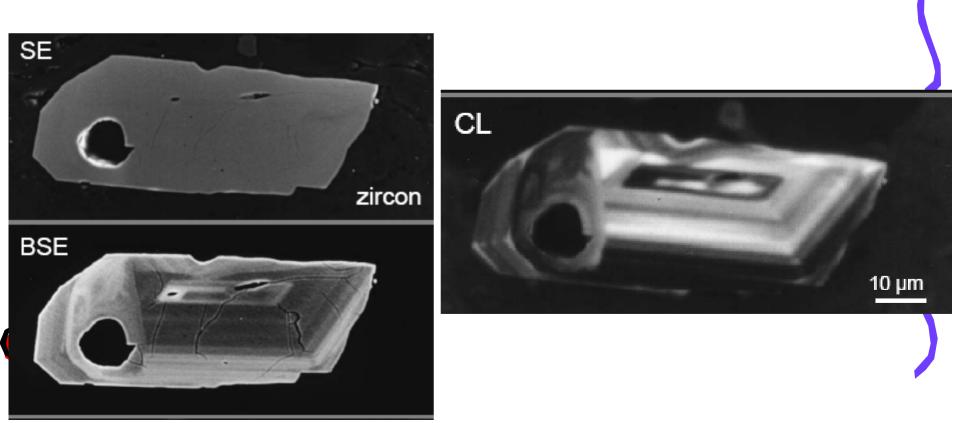


3



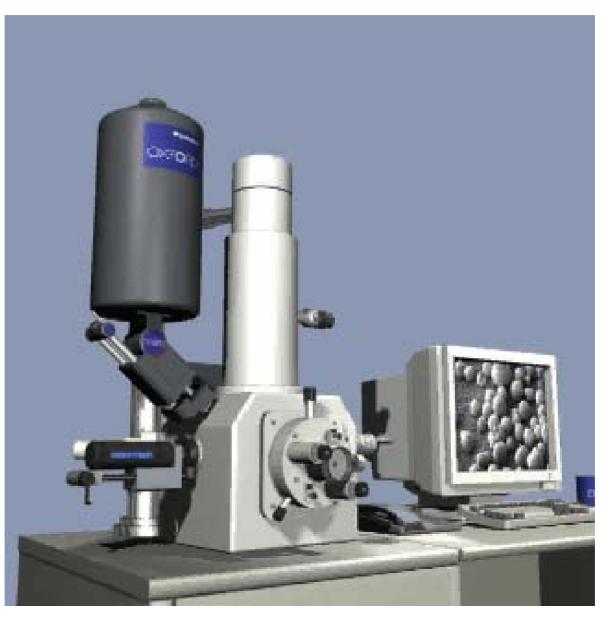
# Advantage of CL

 Imaging structural and chemical variations in nonconductive materials, which are not able viewed by other techniques.

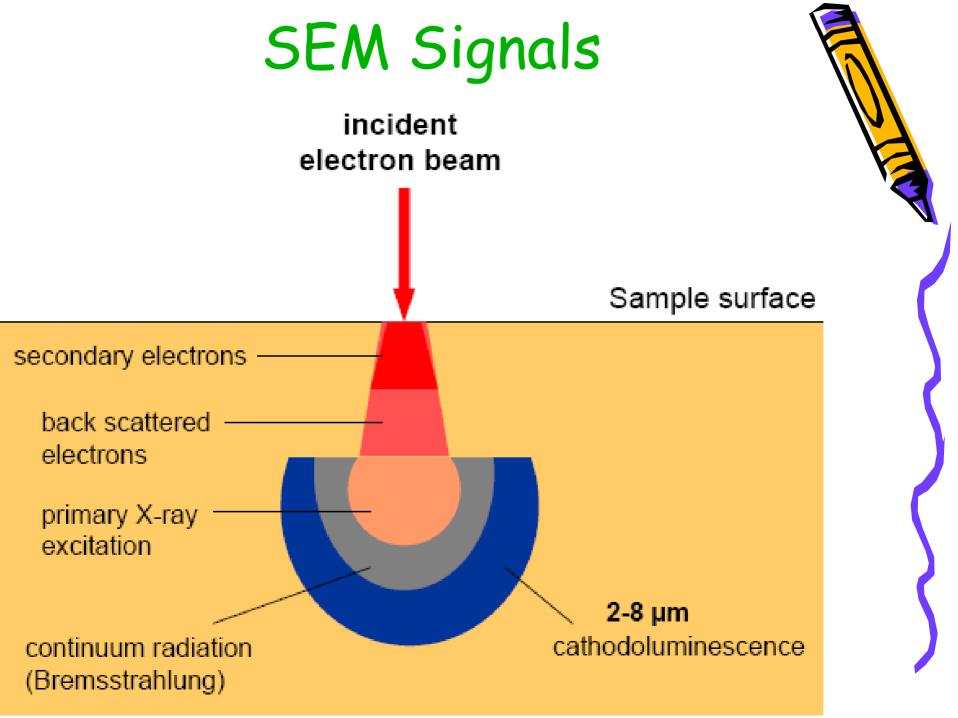




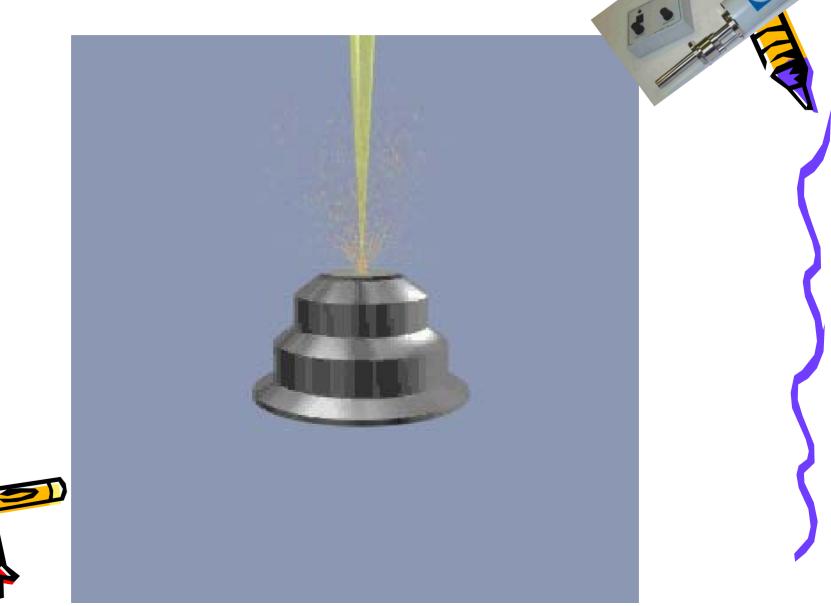
# SEM and SEM-CL











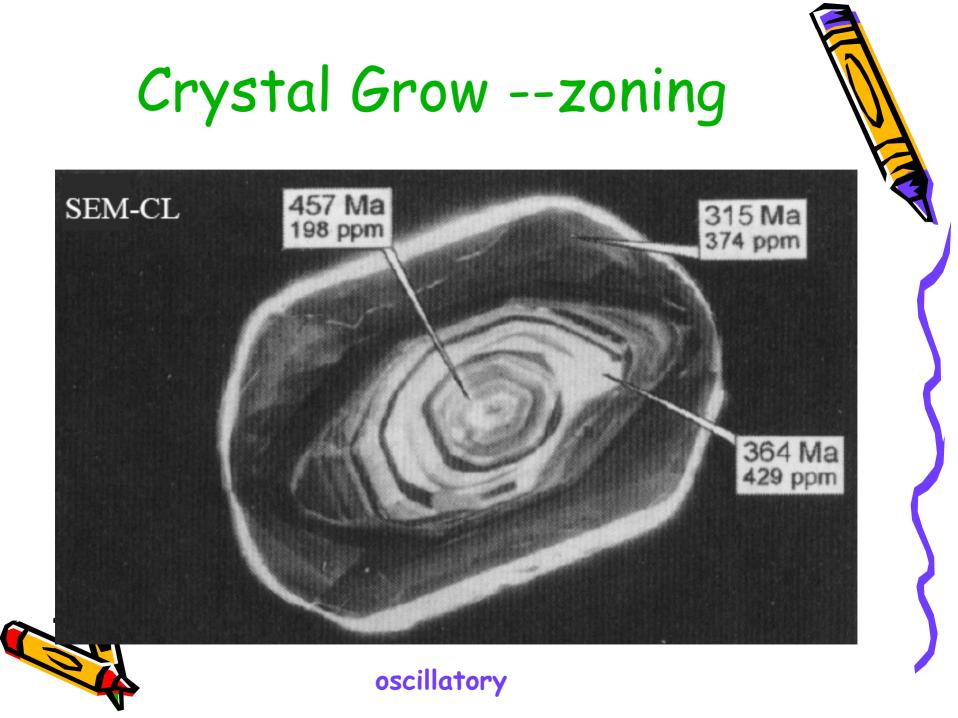
# Applications

- Identification of minerals, mineral distribution
- Crystal chemistry
- Primary & secondary microstructure (growth zoning, deformation features, fluid flow, etc.)
- Reconstruction of geological process (mineral formation, alteration, diagenesis)

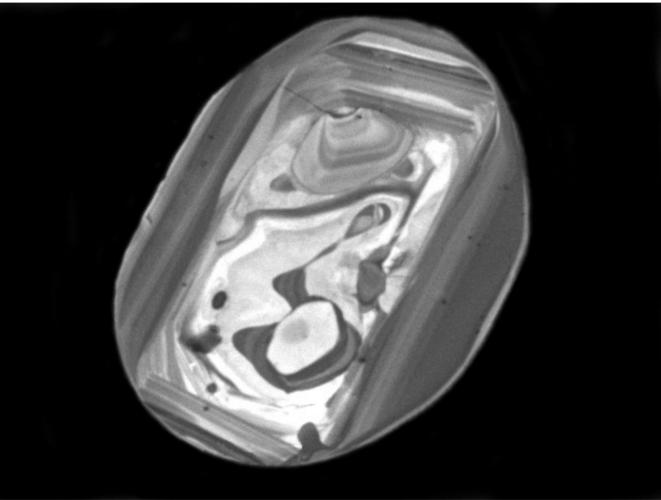
### Crystal Chemistry SEM-CL of Diamond



The growth zones reflect small variations in Nitrogen composition (0 to 1226 ppm).

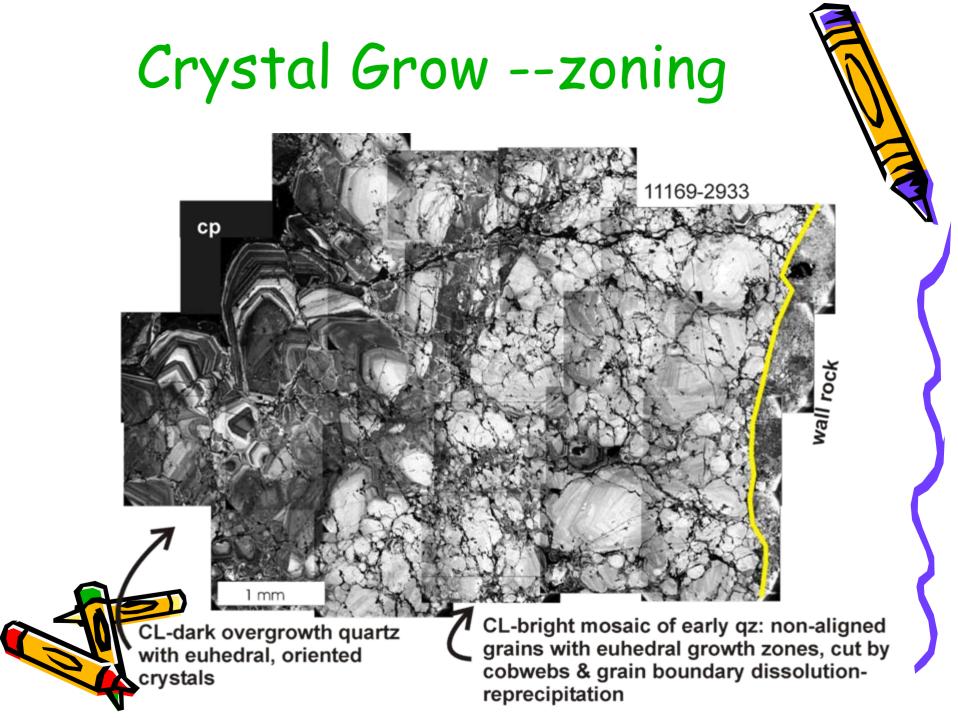


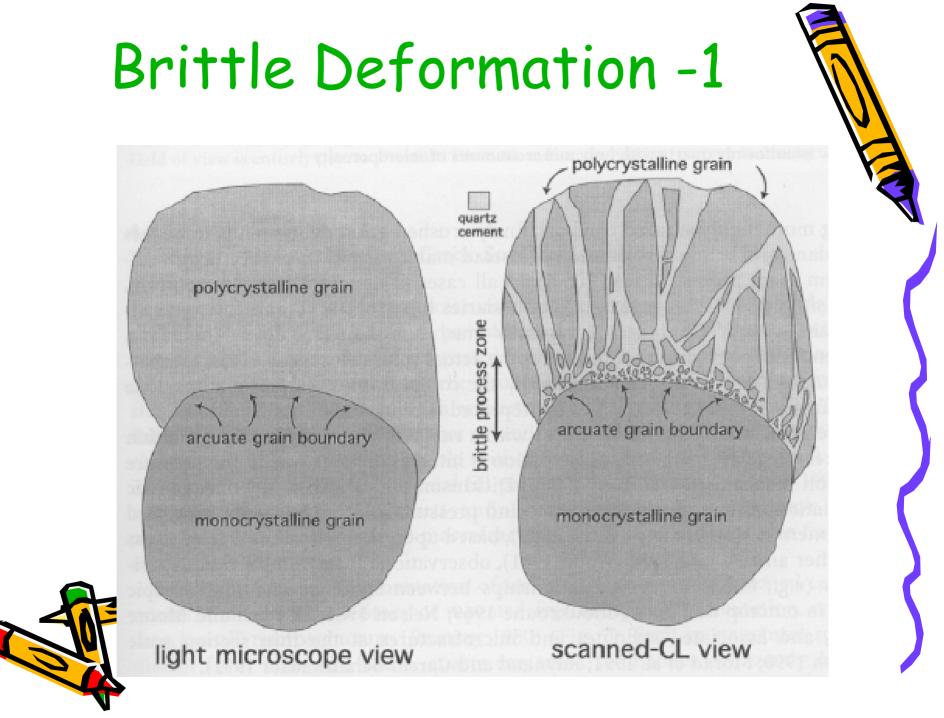
# Crystal Grow --zoning







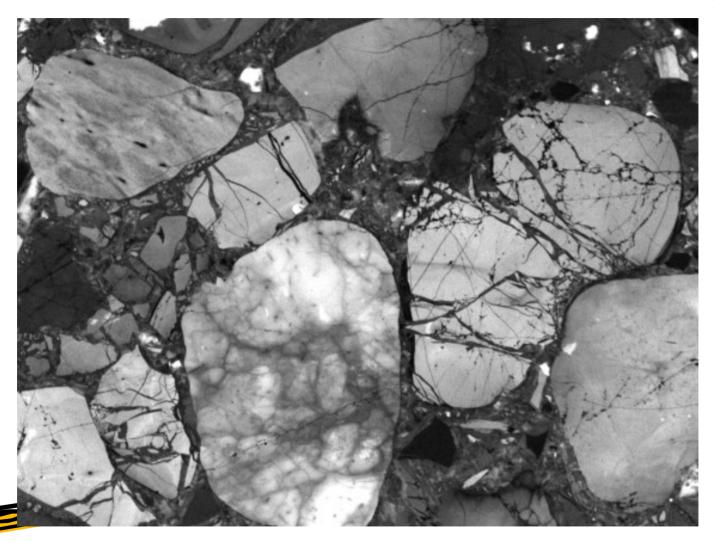




# Brittle Deformation -1



### Micro fracturing --sandstone



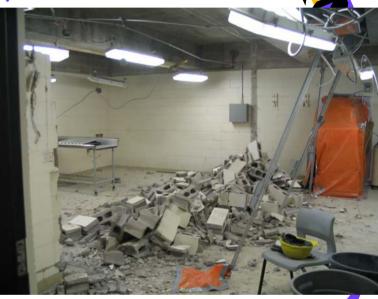
The image shows a series of quartz grains exhibiting typical pressure solution textures and shows graphically that pressure solution is associated with microfracturing.

### Question?



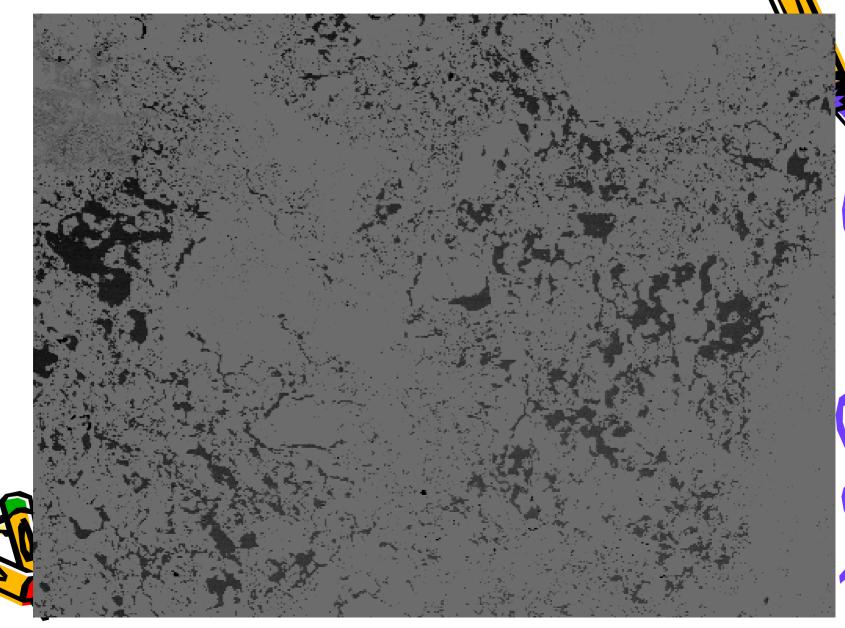
# Safety Rules in the lab

- Construction in the basement, do not enter construction area.
- No practical joke in lab
- No food and drink in the lab



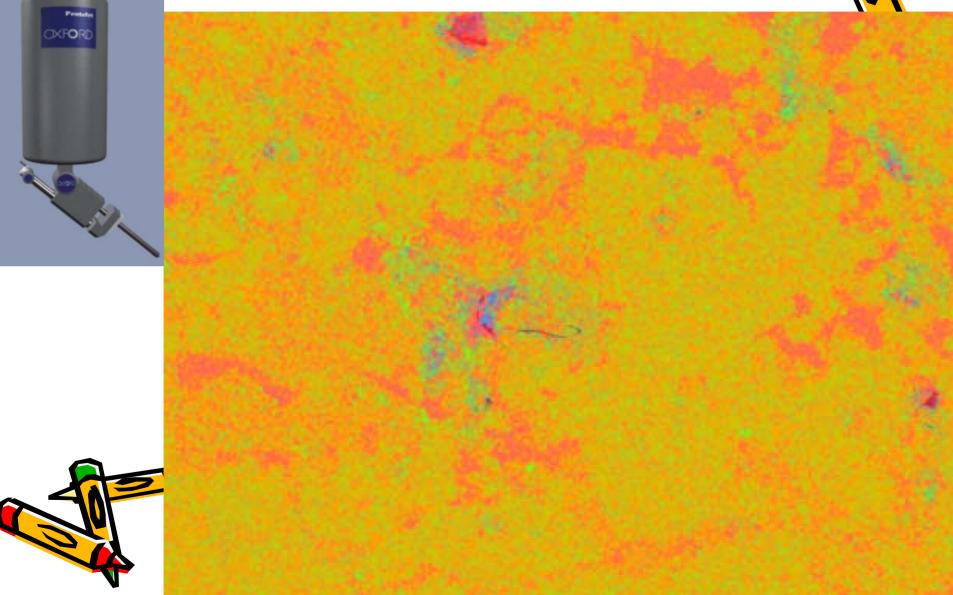
• Do not try to operate any instruments in the

### Lab tour-1 Searching For "K"

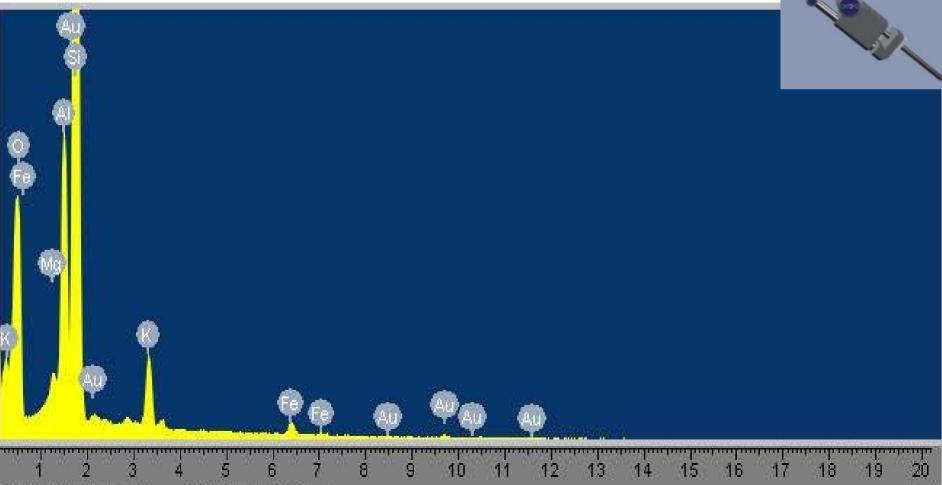


# Lab tour-1 Energy Map-"cameo"





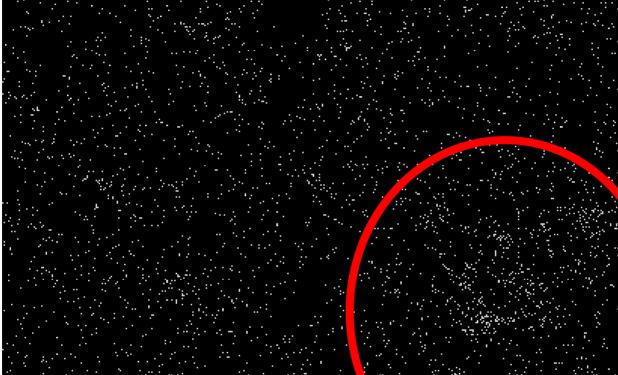
# Lab tour-1 EDS Spectrum



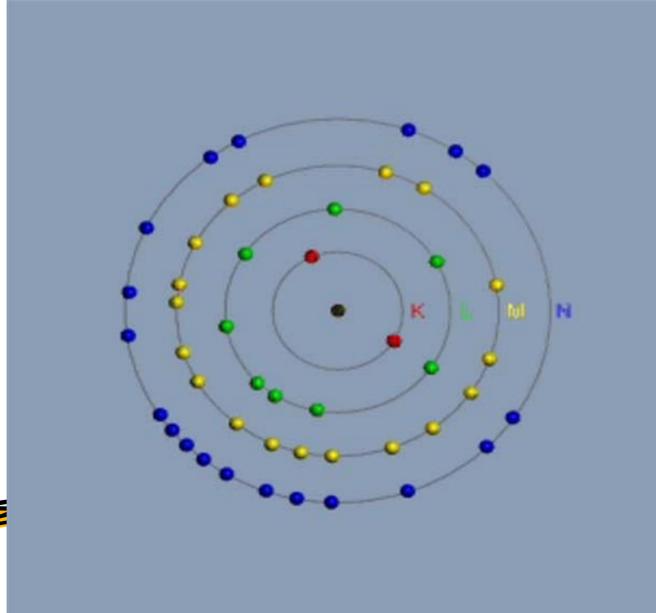
keV

Full Scale 6035 cts. Cursor: 0.086 keV (599 cts)

# Lab tour-1 Distribution of "K"

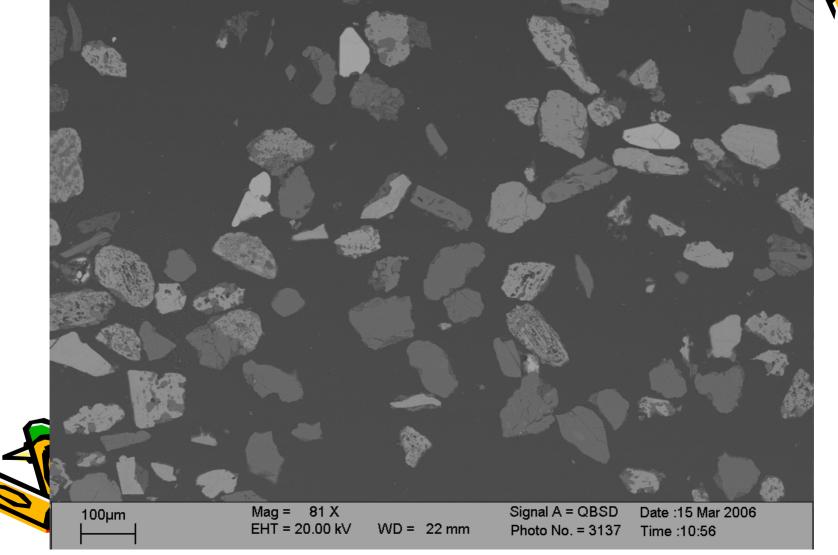


# Basic of X-ray element analysis





## Lab tour-2 Zircon and Zoning Information

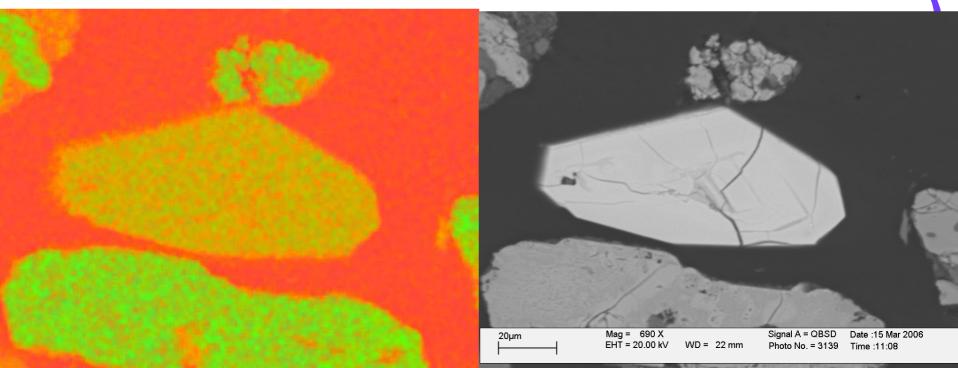


### Lab tour

 Locate a zircon particle with combination of other techniques e.g. Energy Dispersive Spectrometry, Back Scattered Electron Detector

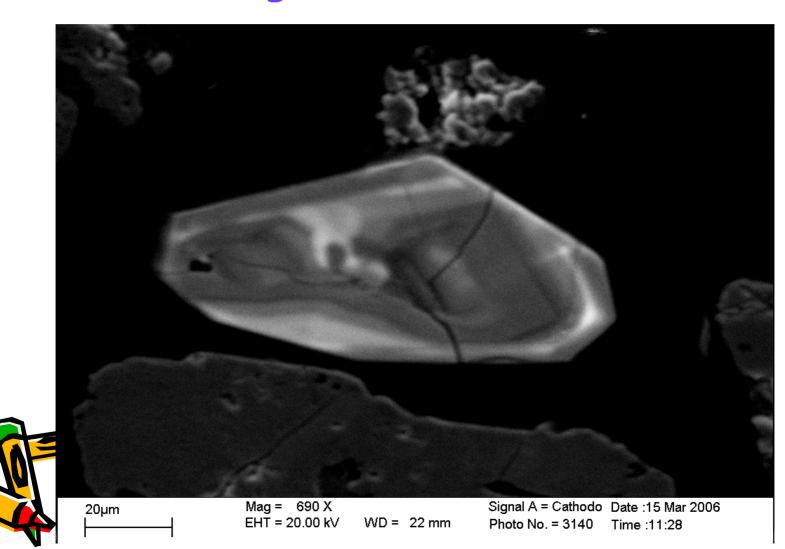
**EDS Mapping** 

**BSD** Imaging



### Lab tour

#### • Zircon CL image



### Lab tour

#### 2 more (preset) zircon particles viewing

F



### Be Patient

because

# image acquisition takes time

